

# IRFI9634GPbF

- Advanced Process Technology
  - Dynamic dv/dt Rating
  - 150°C Operating Temperature
  - Fast Switching
  - P-Channel
  - Fully Avalanche Rated
  - Lead-Free
- Description**

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness. Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 Fullpak eliminates the need for additional insulating hardware in commercial-industrial applications. The moulding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heatsink using a single clip or by a single screw fixing.

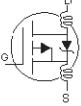
## Absolute Maximum Ratings

	Parameter	Max.	Units
$I_D @ T_C = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ -10\text{V}$	-4.1	
$I_D @ T_C = 100^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ -10\text{V}$	-2.6	A
$I_{DM}$	Pulsed Drain Current <sup>①</sup>	-16	
$P_D @ T_C = 25^\circ\text{C}$	Power Dissipation	35	W
$V_{GS}$	Linear Derating Factor	0.28	$\text{W}/^\circ\text{C}$
$E_{AS}$	Gate-to-Source Voltage	$\pm 20$	V
$I_{AR}$	Single Pulse Avalanche Energy <sup>②</sup>	520	mJ
$E_{AR}$	Avalanche Current <sup>①</sup>	-4.1	A
$dv/dt$	Repetitive Avalanche Energy <sup>①</sup>	3.5	mJ
$T_J$	Peak Diode Recovery dv/dt <sup>③</sup>	-5.0	$\text{V}/\text{ns}$
$T_{STG}$	Operating Junction and Storage Temperature Range	-55 to + 150	$^\circ\text{C}$
	Soldering Temperature, for 10 seconds	300 (1.6mm from case )	
	Mounting torque, 6-32 or M3 screw	10 lbf·in (1.1N·m)	

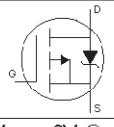
## Thermal Resistance

	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	3.6	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Junction-to-Ambient	—	65	

**Electrical Characteristics @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

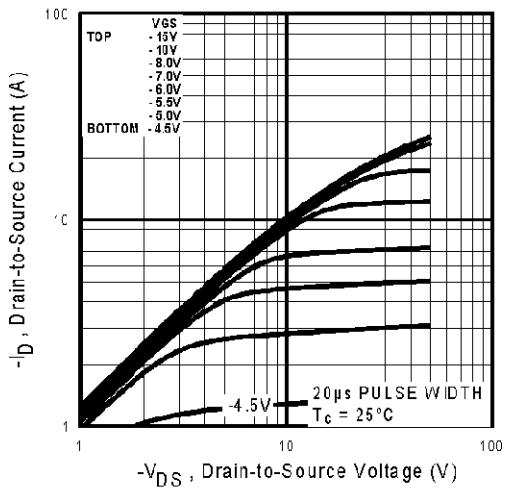
	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	-250	—	—	V	$V_{GS} = 0V, I_D = -250\mu\text{A}$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	-0.27	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = -1\text{mA}$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	1.0	$\Omega$	$V_{GS} = -10V, I_D = -2.5\text{A}$ ④
$V_{GS(th)}$	Gate Threshold Voltage	-2.0	—	-4.0	V	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$
$g_{f\text{e}}$	Forward Transconductance	2.2	—	—	S	$V_{DS} = -50V, I_D = -4.1\text{A}$
$I_{DSS}$	Drain-to-Source Leakage Current	—	—	-25	$\mu\text{A}$	$V_{DS} = -250V, V_{GS} = 0V$
		—	—	-250		$V_{DS} = -200V, V_{GS} = 0V, T_J = 150^\circ\text{C}$
$I_{GSS}$	Gate-to-Source Forward Leakage	—	—	100	$\text{nA}$	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -20V$
$Q_g$	Total Gate Charge	—	—	38	$\text{nC}$	$I_D = -4.1\text{A}$
$Q_{gs}$	Gate-to-Source Charge	—	—	8.0		$V_{DS} = -200V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge	—	—	18		$V_{GS} = -10V$ , See Fig. 6 and 13 ④
$t_{d(on)}$	Turn-On Delay Time	—	12	—	$\text{ns}$	$V_{DD} = -130V$
$t_r$	Rise Time	—	23	—		$I_D = -4.1\text{A}$
$t_{d(off)}$	Turn-Off Delay Time	—	34	—		$R_C = 12\Omega$
$t_f$	Fall Time	—	21	—		$R_D = 31\Omega$ , See Fig. 10 ④
$L_D$	Internal Drain Inductance	—	4.5	—	$\text{nH}$	Between lead, 6mm (0.25in.) from package and center of die contact
$L_S$	Internal Source Inductance	—	7.5	—		
$C_{iss}$	Input Capacitance	—	680	—		$V_{GS} = 0V$
$C_{css}$	Output Capacitance	—	170	—	$\text{pF}$	$V_{DS} = -25V$
$C_{rss}$	Reverse Transfer Capacitance	—	40	—		$f = 1.0\text{MHz}$ , See Fig. 5
$C$	Drain to Sink Capacitance	—	12	—		$f = 1.0\text{MHz}$

**Source-Drain Ratings and Characteristics**

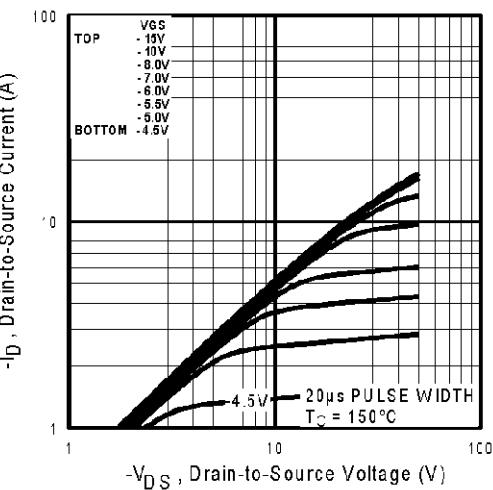
	Parameter	Min.	Typ.	Max.	Units	Conditions
$I_S$	Continuous Source Current (Body Diode)	—	—	-4.1	$A$	MOSFET symbol showing the integral reverse p-n junction diode.
$I_{SM}$	Pulsed Source Current (Body Diode) ①	—	—	-16		
$V_{SD}$	Diode Forward Voltage	—	—	-6.5	V	$T_J = 25^\circ\text{C}, I_S = -4.1\text{A}, V_{GS} = 0V$ ④
$t_{rr}$	Reverse Recovery Time	—	190	290	ns	$T_J = 25^\circ\text{C}, I_F = -4.1\text{A}$
$Q_{rr}$	Reverse Recovery Charge	—	1.5	2.2	$\mu\text{C}$	$dI/dt = -100\text{A}/\mu\text{s}$ ④
$t_{or}$	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$ )				

**Notes:**

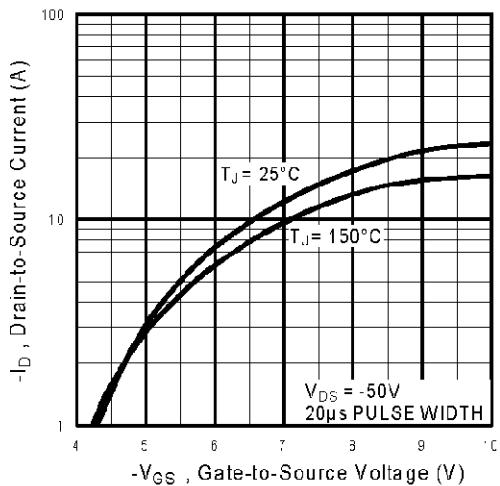
- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- ③  $I_{SD} \leq -4.1\text{A}$ ,  $dI/dt \leq -640\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 150^\circ\text{C}$
- ② Starting  $T_J = 25^\circ\text{C}$ ,  $L = 62\text{mH}$ ,  $R_G = 25\Omega$ ,  $I_{AS} = -4.1\text{A}$ . (See Figure 12)
- ④ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .



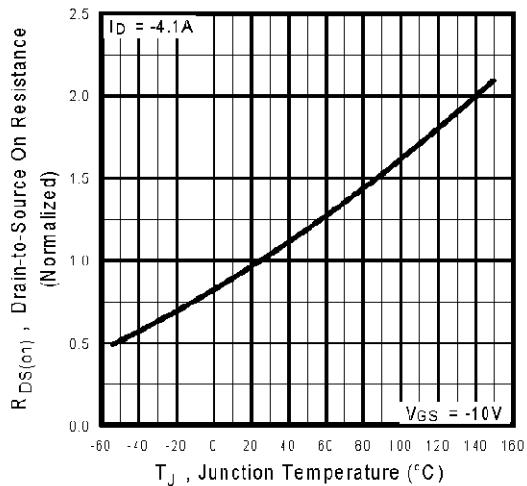
**Fig 1.** Typical Output Characteristics,  
 $T_J = 25^\circ\text{C}$



**Fig 2.** Typical Output Characteristics,  
 $T_J = 150^\circ\text{C}$



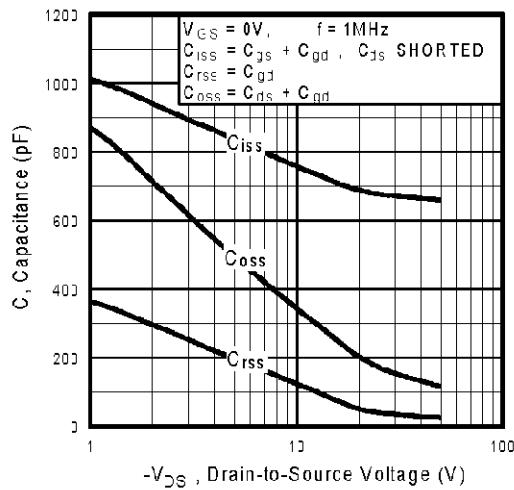
**Fig 3.** Typical Transfer Characteristics



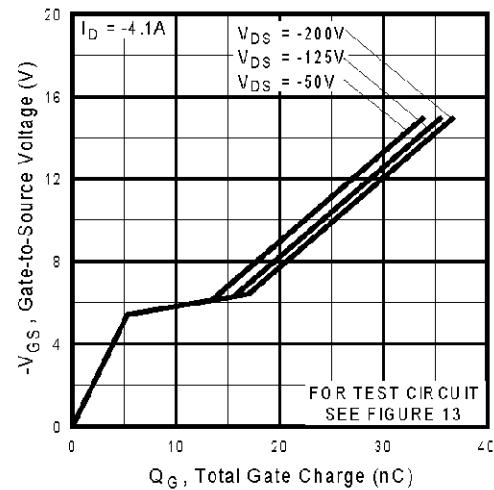
**Fig 4.** Normalized On-Resistance  
Vs. Temperature

# IRFI9634GPbF

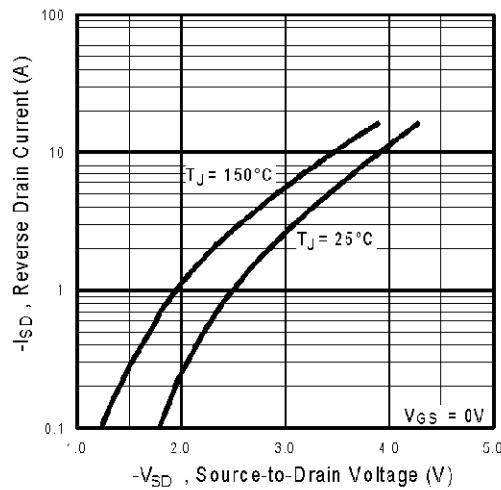
International  
Rectifier



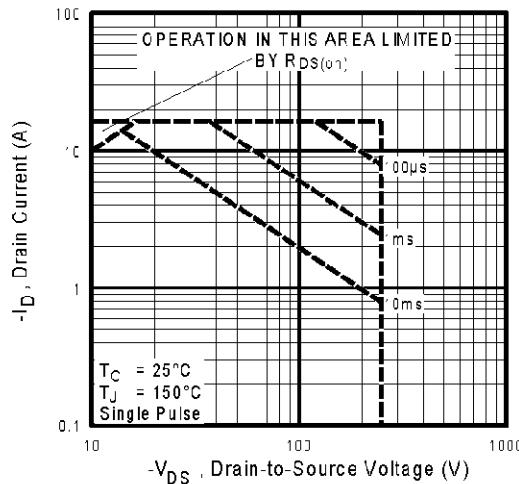
**Fig 5.** Typical Capacitance Vs.  
Drain-to-Source Voltage



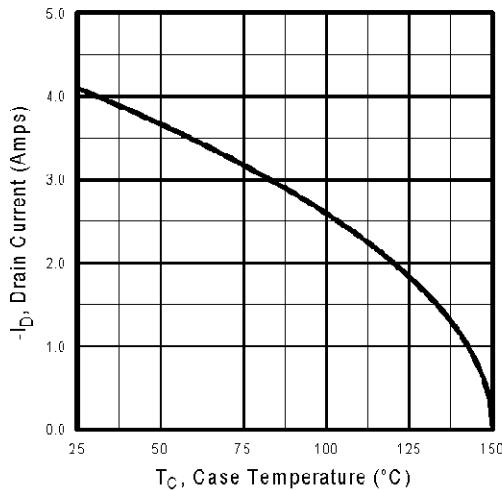
**Fig 6.** Typical Gate Charge Vs.  
Gate-to-Source Voltage



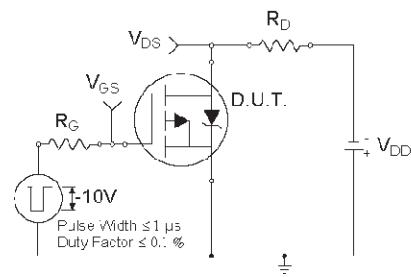
**Fig 7.** Typical Source-Drain Diode  
Forward Voltage



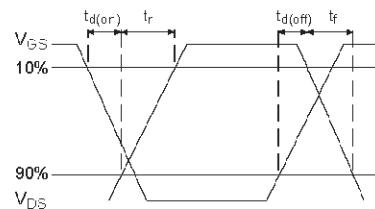
**Fig 8.** Maximum Safe Operating Area



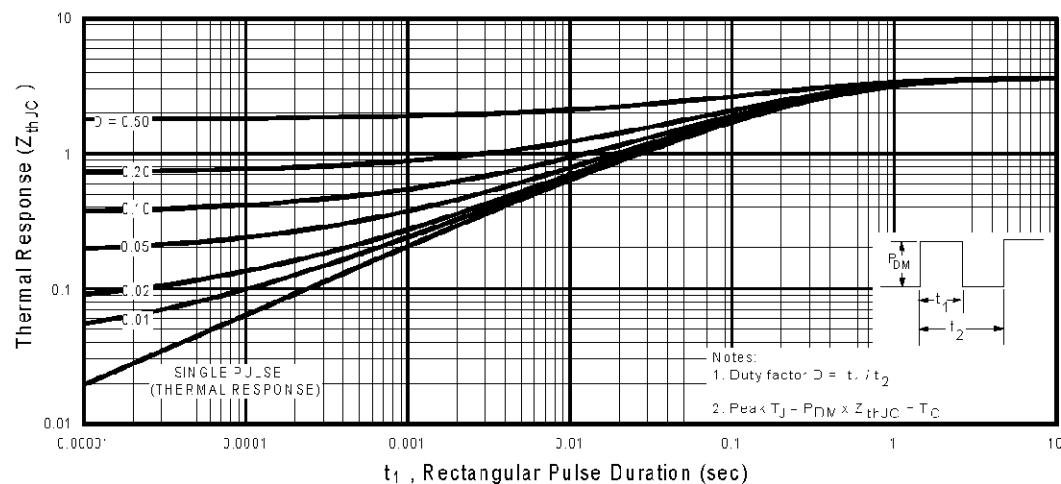
**Fig 9.** Maximum Drain Current Vs.  
Case Temperature



**Fig 10a.** Switching Time Test Circuit



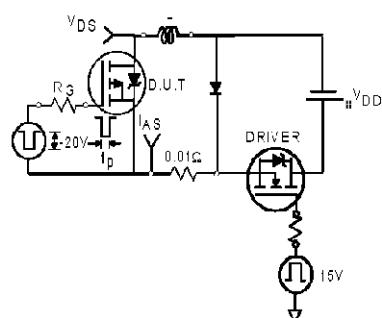
**Fig 10b.** Switching Time Waveforms



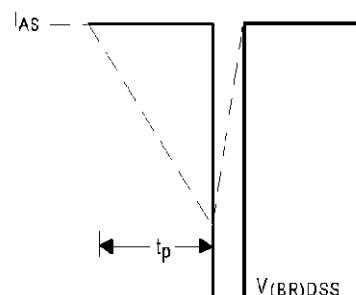
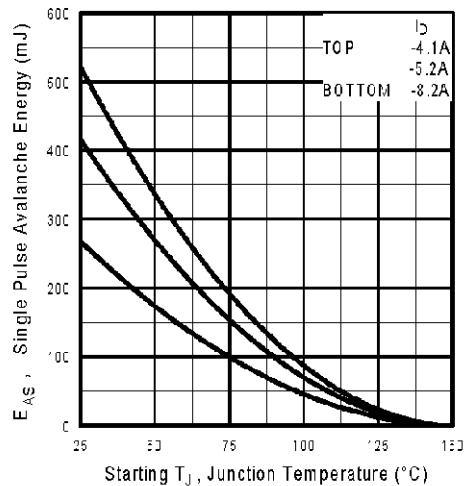
**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

# IRFI9634GPbF

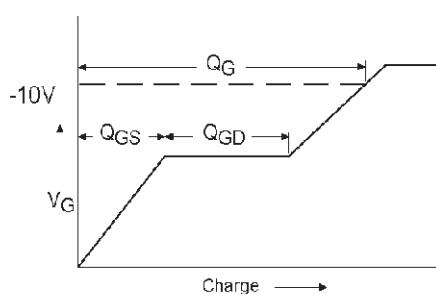
International  
**IR** Rectifier



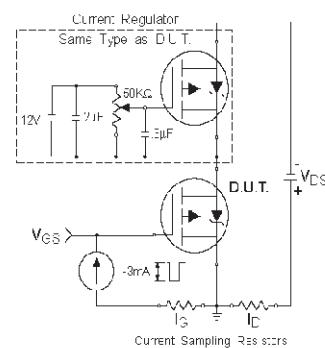
**Fig 12a.** Unclamped Inductive Test Circuit



**Fig 12b.** Unclamped Inductive Waveforms

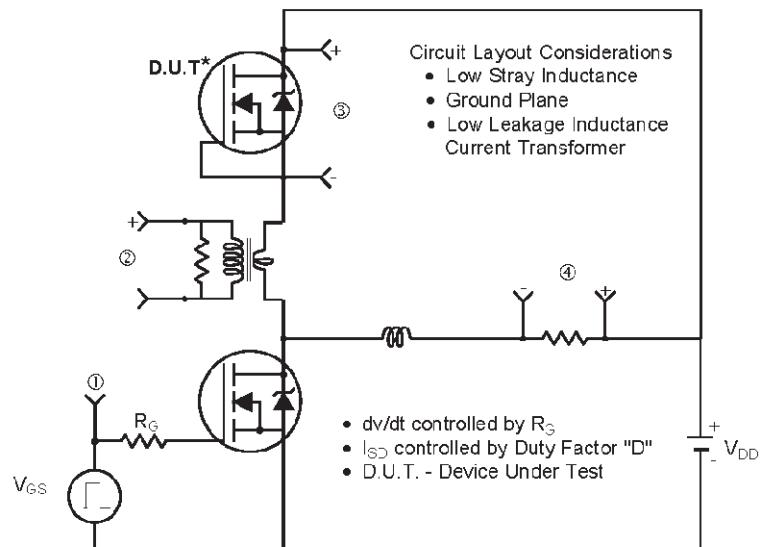


**Fig 13a.** Basic Gate Charge Waveform

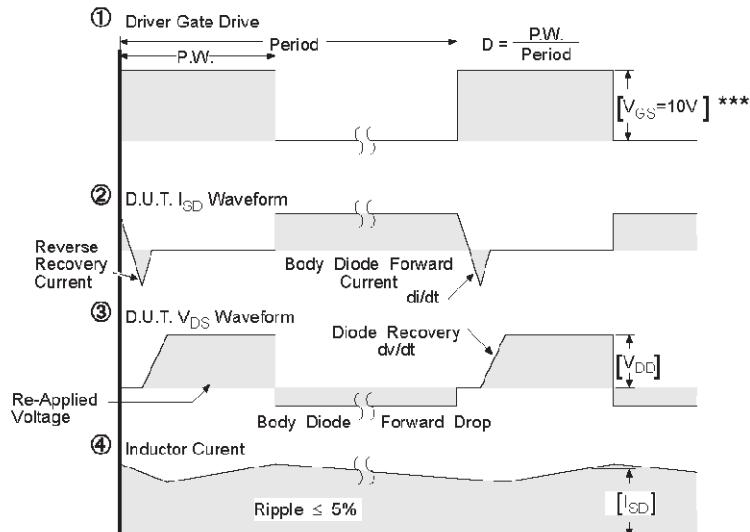


**Fig 13b.** Gate Charge Test Circuit

## Peak Diode Recovery dv/dt Test Circuit



\* Reverse Polarity of D.U.T for P-Channel



\*\*\*  $V_{GS} = 5.0V$  for Logic Level and 3V Drive Devices

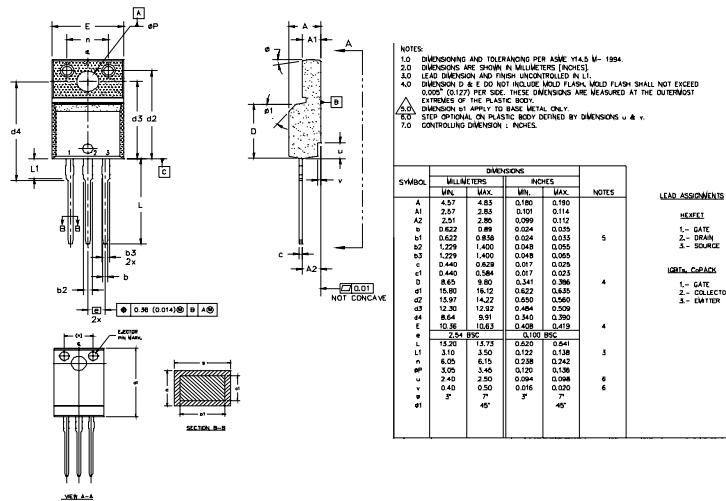
**Fig 14.** For P-Channel HEXFETs

# IRFI9634GPbF

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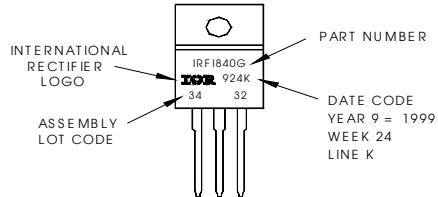
## TO-220 Full-Pak Package Outline

Dimensions are shown in millimeters (inches)



## TO-220 Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRFI840G  
WITH ASSEMBLY  
LOT CODE 3432  
ASSEMBLED ON WW 24 1999  
IN THE ASSEMBLY LINE "K"  
  
Note: "P" in assembly line  
position indicates "Lead-Free"



Data and specifications subject to change without notice.

International  
ICR Rectifier

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TAC Fax: (310) 252-7903  
07/04



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